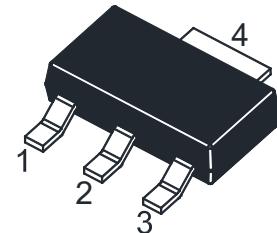
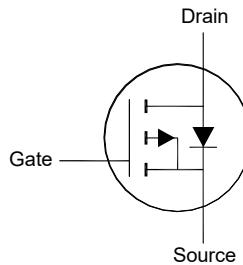


WTQ10P2K6LS-HAF

P-Channel Enhancement Mode MOSFET

Features

- Surface-mounted package
- Low Gate-Source Threshold Voltage
- Halogen and Antimony Free(HAF), RoHS compliant



1.Gate 2.Drain 3.Source 4.Drain
SOT-223 Plastic Package

Key Parameters

Parameter	Value	Unit
-BV _{DSS}	100	V
R _{DS(ON)} Max	310 @ -V _{GS} = 10 V	mΩ
	340 @ -V _{GS} = 4.5 V	
-V _{GS(th)} typ	2	V
Q _g typ	16 @ -V _{GS} = 10 V	nC

Absolute Maximum Ratings (at T_a = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	-V _{DS}	100	V
Gate-Source Voltage	V _{GS}	± 20	V
Drain Current	-I _D	5	A
		3	
Peak Drain Current ¹⁾	-I _{DM}	14	A
Avalanche Current	-I _{AS}	6.6	A
Avalanche Energy ²⁾	E _{AS}	2.2	mJ
Power Dissipation	P _D	10	W
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to + 150	°C

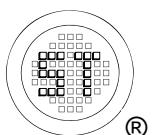
Thermal Characteristics

Parameter	Symbol	Max.	Unit
Thermal Resistance - Junction to Case	R _{θJC}	12	°C/W
Thermal Resistance - Junction to Ambient ³⁾ Steady State	R _{θJA}	50	°C/W

¹⁾ Pulse Test: Pulse Width ≤ 100 µs, Duty Cycle ≤ 2%, Repetitive rating, pulse width limited by junction temperature T_{J(MAX)} = 150°C.

²⁾ Limited by T_{J(MAX)}, starting T_J = 25°C, L = 0.1 mH, R_g = 25 Ω, -I_{AS} = 6.6 A, V_{GS} = 10 V.

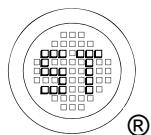
³⁾ Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate in still air.



WTQ10P2K6LS-HAF

Characteristics at $T_a = 25^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	Min.	Typ.	Max.	Unit
STATIC PARAMETERS					
Drain-Source Breakdown Voltage at $-I_D = 250 \mu\text{A}$	$-V_{(\text{BR})\text{DSS}}$	100	-	-	V
Drain-Source On-State Current at $-V_{DS} = 80 \text{ V}$	$-I_{\text{DSS}}$	-	-	1	μA
Gate-Source Leakage Current at $V_{GS} = \pm 20 \text{ V}$	I_{GSS}	-	-	± 100	nA
Gate-Source Threshold Voltage at $V_{DS} = V_{GS}$, $-I_D = 250 \mu\text{A}$	$-V_{GS(\text{th})}$	1.2	-	2.5	V
Drain-Source On-State Resistance at $-V_{GS} = 10 \text{ V}$, $-I_D = 5 \text{ A}$ at $-V_{GS} = 4.5 \text{ V}$, $-I_D = 4 \text{ A}$	$R_{\text{DS(ON)}}$	-	280	310 340	$\text{m}\Omega$
DYNAMIC PARAMETERS					
Forward Transconductance at $-V_{DS} = 5 \text{ V}$, $-I_D = 5 \text{ A}$	g_{fs}	-	8	-	S
Gate resistance at $V_{GS} = 0 \text{ V}$, $V_{DS} = 0 \text{ V}$, $f = 1 \text{ MHz}$	R_g	-	7.1	-	Ω
Input Capacitance at $V_{GS} = 0 \text{ V}$, $-V_{DS} = 50 \text{ V}$, $f = 1 \text{ MHz}$	C_{iss}	-	1046	-	pF
Output Capacitance at $V_{GS} = 0 \text{ V}$, $-V_{DS} = 50 \text{ V}$, $f = 1 \text{ MHz}$	C_{oss}	-	29	-	pF
Reverse Transfer Capacitance at $V_{GS} = 0 \text{ V}$, $-V_{DS} = 50 \text{ V}$, $f = 1 \text{ MHz}$	C_{rss}	-	25	-	pF
Total Gate Charge at $-V_{GS} = 10 \text{ V}$, $-V_{DS} = 50 \text{ V}$, $-I_D = 5 \text{ A}$ at $-V_{GS} = 4.5 \text{ V}$, $-V_{DS} = 50 \text{ V}$, $-I_D = 5 \text{ A}$	Q_g	- -	16 7	-	nC
Gate-Source Charge at $-V_{GS} = 10 \text{ V}$, $-V_{DS} = 50 \text{ V}$, $-I_D = 5 \text{ A}$	Q_{gs}	-	4	-	nC
Gate-Drain Charge at $-V_{GS} = 10 \text{ V}$, $-V_{DS} = 50 \text{ V}$, $-I_D = 5 \text{ A}$	Q_{gd}	-	2	-	nC
Turn-On Delay Time at $-V_{GS} = 10 \text{ V}$, $-V_{DD} = 50 \text{ V}$, $-I_D = 5 \text{ A}$, $R_g = 3.3 \Omega$	$t_{d(\text{on})}$	-	8	-	ns
Turn-On Rise Time at $-V_{GS} = 10 \text{ V}$, $-V_{DD} = 50 \text{ V}$, $-I_D = 5 \text{ A}$, $R_g = 3.3 \Omega$	t_r	-	4	-	ns
Turn-Off Delay Time at $-V_{GS} = 10 \text{ V}$, $-V_{DD} = 50 \text{ V}$, $-I_D = 5 \text{ A}$, $R_g = 3.3 \Omega$	$t_{d(\text{off})}$	-	12	-	ns
Turn-Off Fall Time at $-V_{GS} = 10 \text{ V}$, $-V_{DD} = 50 \text{ V}$, $-I_D = 5 \text{ A}$, $R_g = 3.3 \Omega$	t_f	-	4	-	ns
Body-Diode PARAMETERS					
Drain-Source Diode Forward Voltage at $-I_S = 1 \text{ A}$, $V_{GS} = 0 \text{ V}$	$-V_{SD}$	-	-	1.2	V
Body-Diode Continuous Current	$-I_S$	-	-	5	A
Body-Diode Continuous Current, Pulsed	$-I_{SM}$	-	-	14	A
Body Diode Reverse Recovery Time at $-I_S = 5 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}$	t_{rr}	-	22	-	ns
Body Diode Reverse Recovery Charge at $-I_S = 5 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}$	Q_{rr}	-	25	-	nC



WTQ10P2K6LS-HAF

Electrical Characteristics Curves

Fig. 1 Typical Output Characteristics

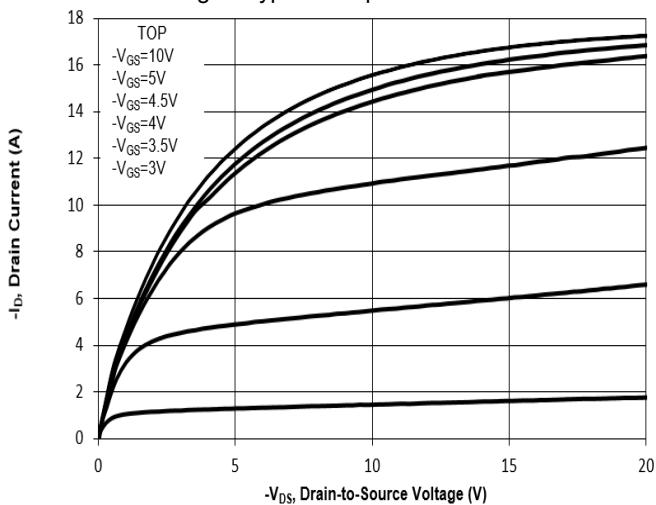


Fig. 2 Typical Transfer Characteristics

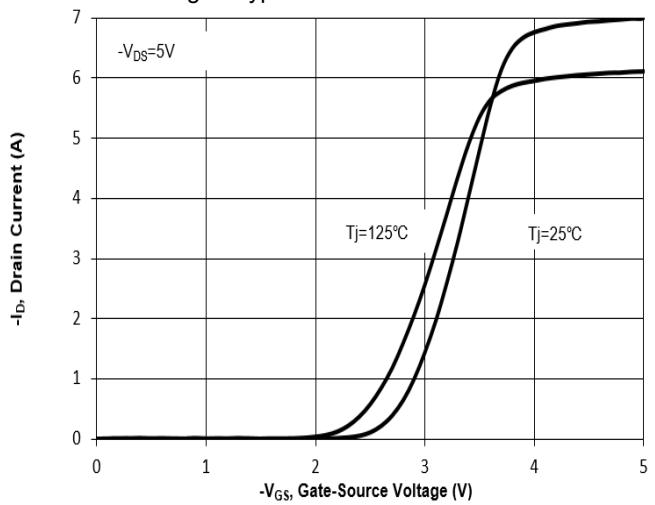


Fig. 3 On-Resistance vs. Drain Current

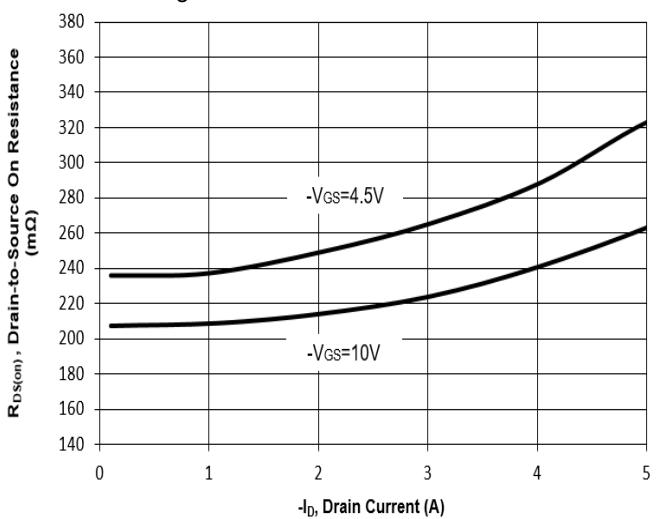


Fig. 4 On-Resistance vs. Gate to Source Voltage

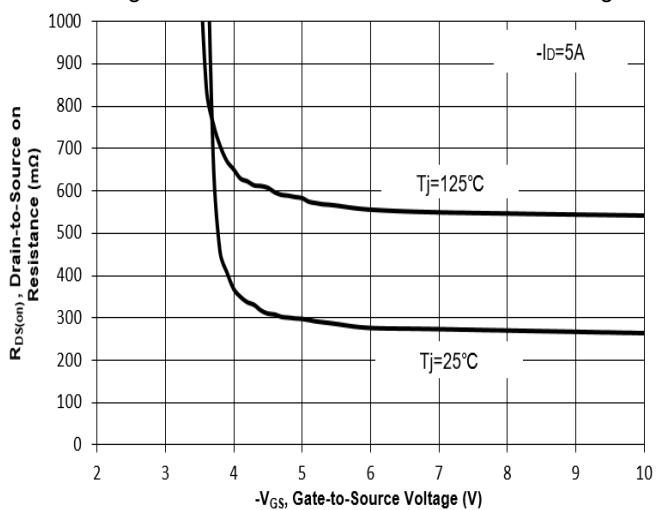


Fig. 5 On-Resistance vs. T_j

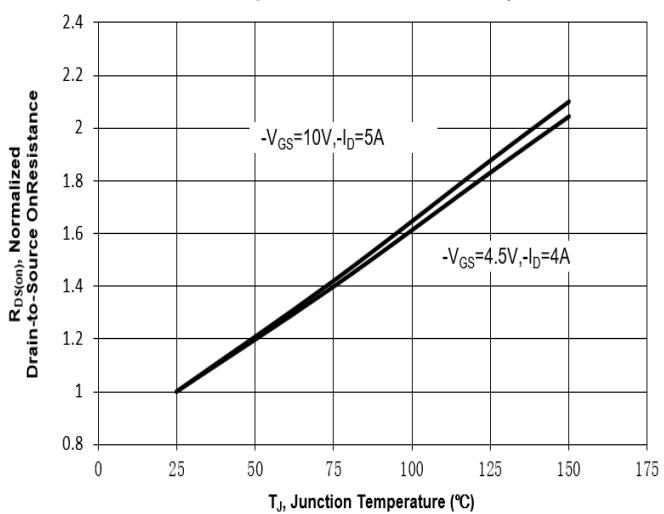
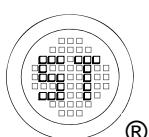
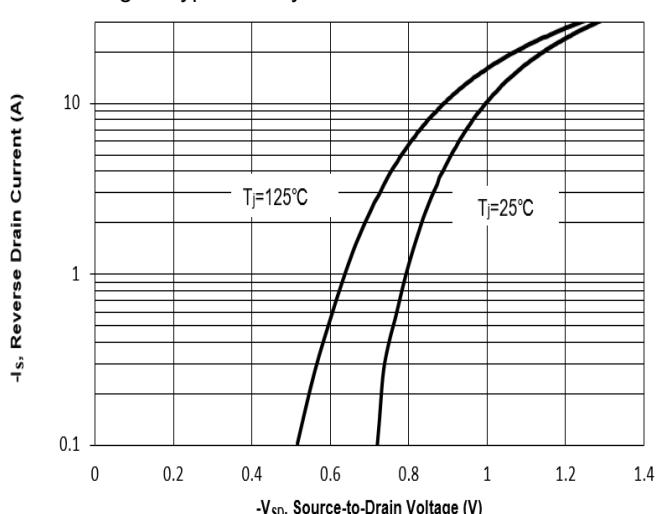


Fig. 6 Typical Body-Diode Forward Characteristics



WTQ10P2K6LS-HAF

Electrical Characteristics Curves

Fig. 7 Typical Junction Capacitance

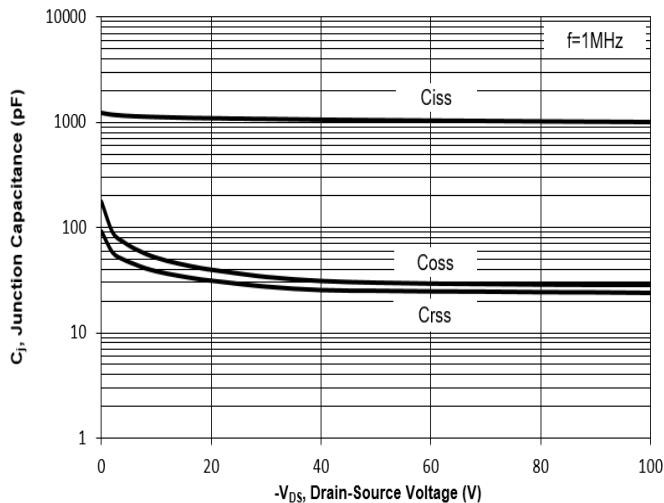


Fig. 8 Drain-Source Leakage Current vs. T_j

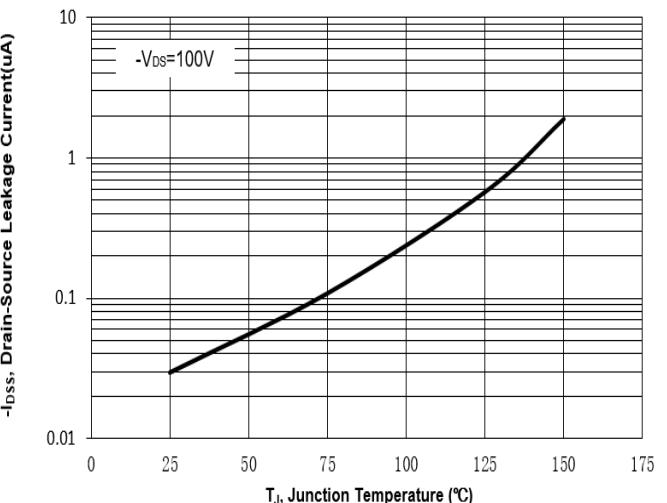


Fig. 9 $V_{(BR)DSS}$ vs. Junction Temperature

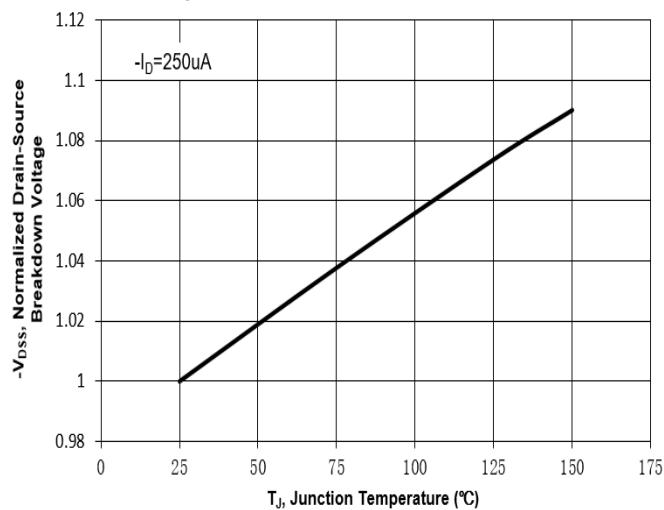


Fig. 10 Gate Threshold Variation vs. T_j

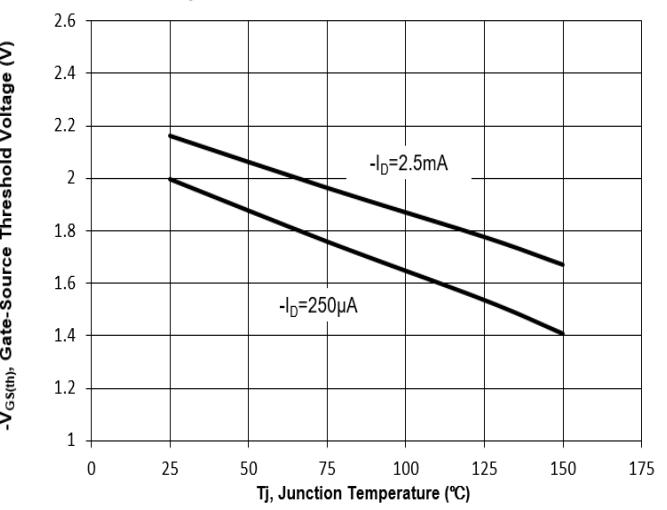


Fig. 11 Gate Charge

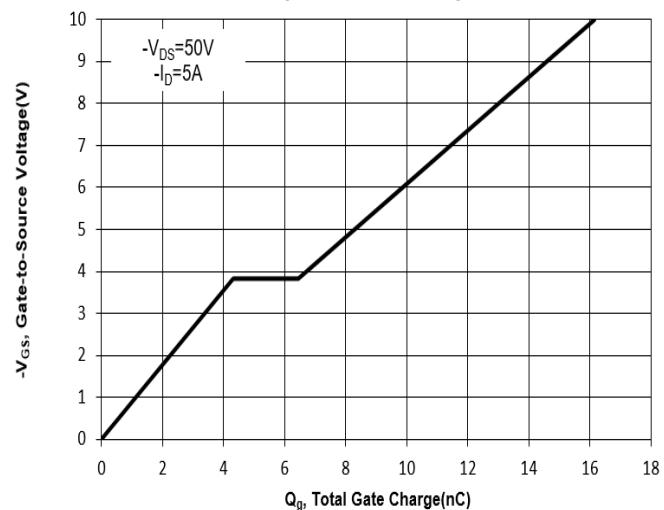
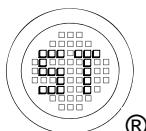
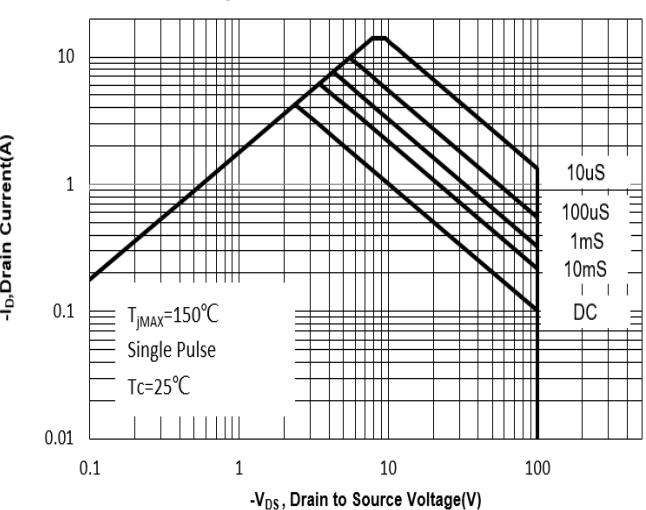


Fig. 12 Safe Operation Area



WTQ10P2K6LS-HAF

Electrical Characteristics Curves

Fig. 13 Normalized Maximum Transient Thermal Impedance(Z_{\thetaJC})

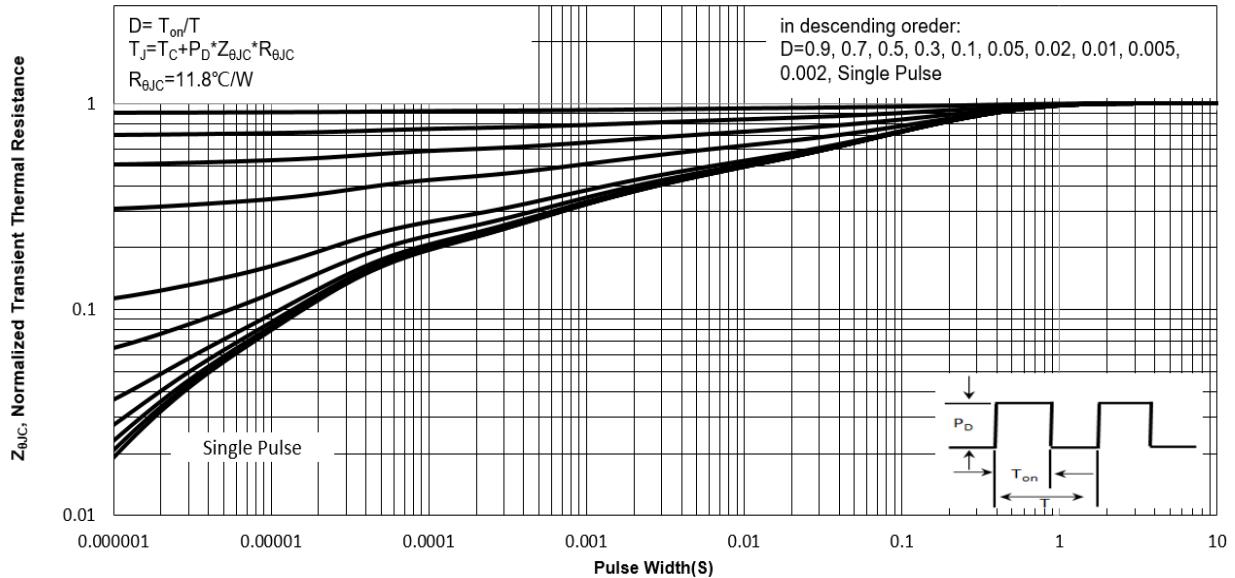
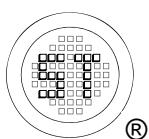
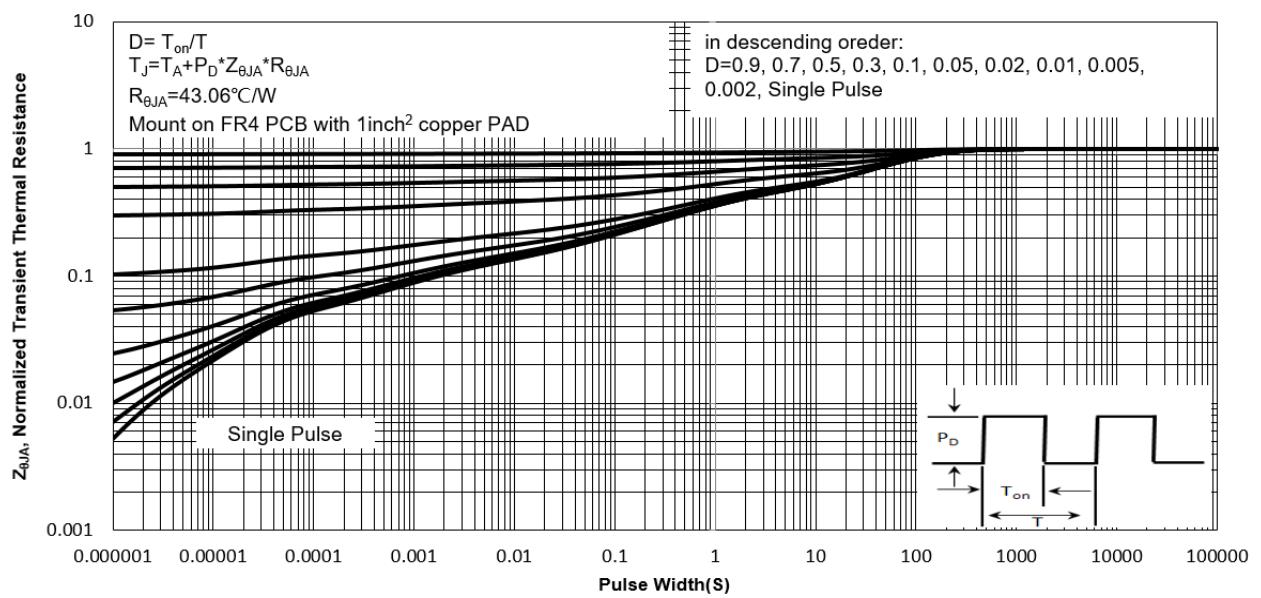


Fig. 14 Normalized Maximum Transient Thermal Impedance(Z_{\thetaJA})



WTQ10P2K6LS-HAF

Test Circuits

Fig.1-1 Switching times test circuit

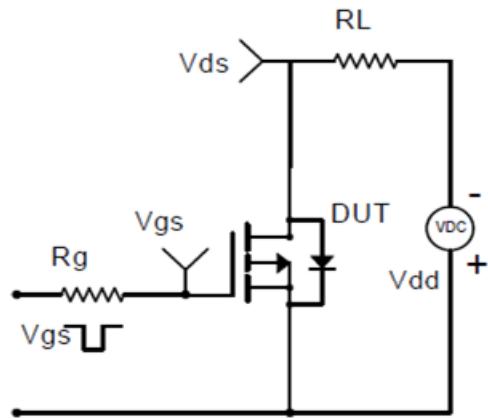


Fig.1-2 Switching Waveform

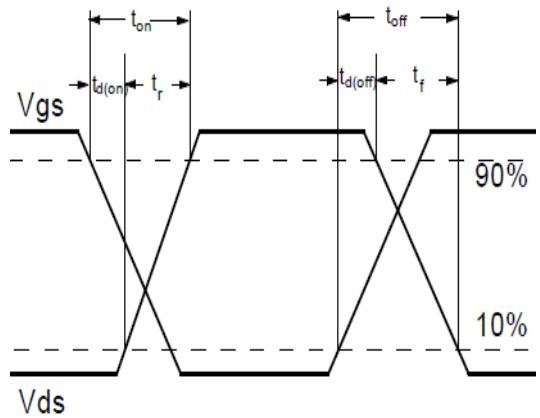


Fig.2-1 Gate charge test circuit

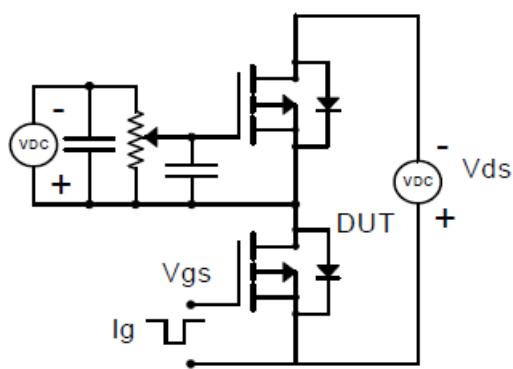


Fig.2-2 Gate charge waveform

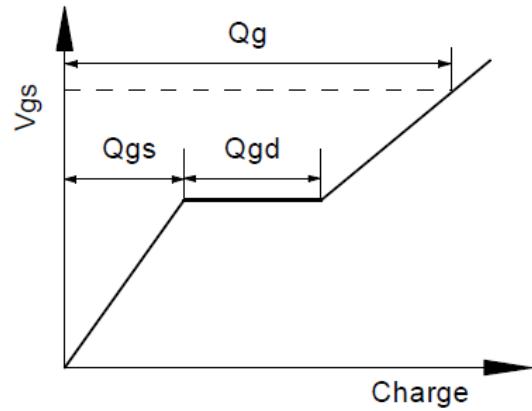


Fig.3-1 Avalanche test circuit

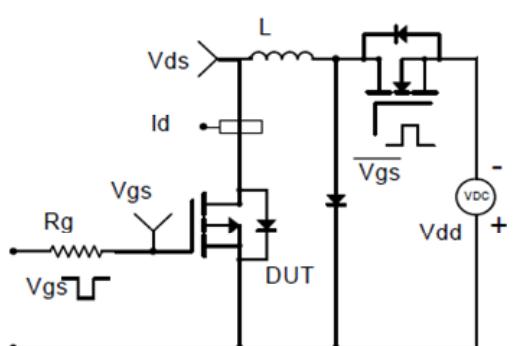
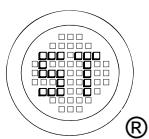
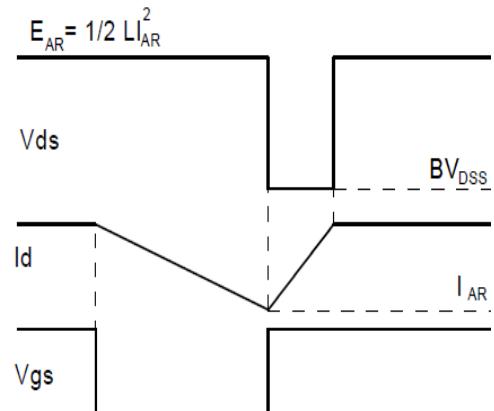


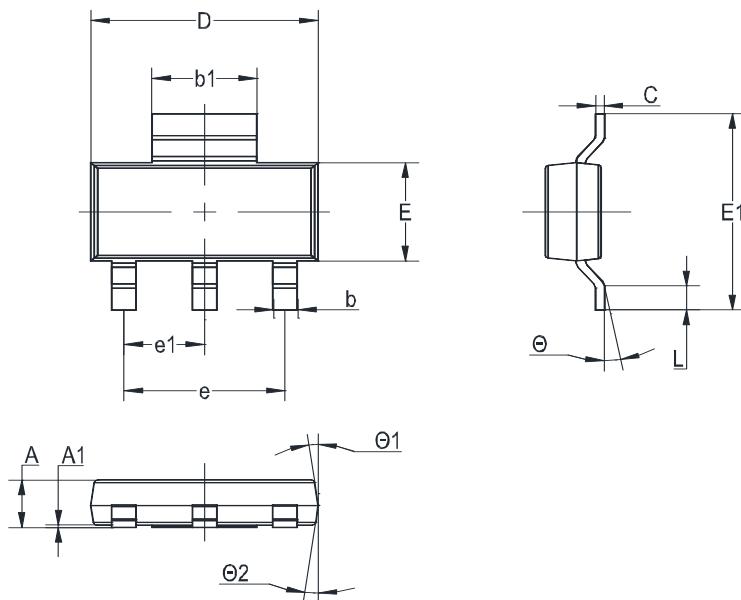
Fig.3-2 Avalanche waveform



WTQ10P2K6LS-HAF

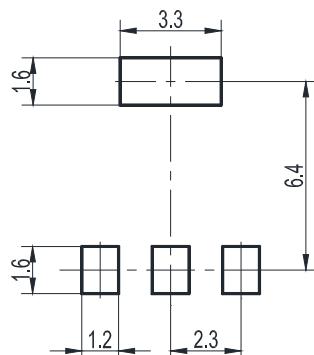
Package Outline (Dimensions in mm)

SOT-223



Unit	A	A1	b	b1	C	D	E	E1	e	e1	L	Θ	Θ1	Θ2
mm	1.8	0.1	0.8	3.1	0.32	6.7	3.7	7.3	4.6	2.3	1.1	10°	7°	7°
	1.5	MAX	0.6	2.9	0.22	6.3	3.3	6.7	TYP	TYP	0.7	0°	0°	0°

Recommended Soldering Footprint



Packing information

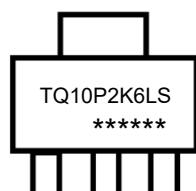
Package	Tape Width (mm)	Pitch		Reel Size		Per Reel Packing Quantity
		mm	inch	mm	inch	
SOT-223	12	8 ± 0.1	0.315 ± 0.004	330	13	3,000

Marking information

" TQ10P2K6LS " = Part No.

" ***** " = Date Code Marking

Font type: Arial



Disclaimer: Our company reserve the right to make modifications, enhancements, improvements, corrections or other changes to improve product design, functions and reliability, anytime without notice.

